

<b>Notice of References Cited</b>	Application/Control No. 10/608,242	Applicant(s)/Patent Under Reexamination KILHAM, LAWRENCE B.	
	Examiner David A. Rogers	Art Unit 2856	Page 1 of 1

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.